

Table 3. ESD Protection Characteristics

Т	est Conditions	Class		
Human Body Model		1 (Minimum)		
Machine Model		M2 (Minimum)		
Charge Device Model	MRF9030MR1 MRF9030MBR1	C7 (Minimum) C6 (Minimum)		

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

NOTE - **<u>CAUTION</u>** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.



Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V _{DS} = 65 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 26 Vdc, V _{GS} = 0 Vdc)	I _{DSS}		—	1	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	—	1	μAdc
On Characteristics	•				
Gate Threshold Voltage (V _{DS} = 10 Vdc, I _D = 100 μAdc)	V _{GS(th)}	2	2.9	4	Vdc
Gate Quiescent Voltage (V _{DS} = 26 Vdc, I _D = 250 mAdc)	V _{GS(Q)}	3	3.8	5	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 0.7 Adc)	V _{DS(on)}	_	0.23	0.4	Vdc
Forward Transconductance (V _{DS} = 10 Vdc, I _D = 2 Adc)	9 _{fs}	_	2.7	—	S
Dynamic Characteristics				ł	•
Input Capacitance (V _{DS} = 26 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{iss}	_	49	_	pF
Output Capacitance (V _{DS} = 26 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{oss}		27		pF
Reverse Transfer Capacitance (V _{DS} = 26 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{rss}	—	1.2	_	pF
Functional Tests (In Freescale Test Fixture)		1			
Two-Tone Common-Source Amplifier Power Gain (V_{DD} = 26 Vdc, P_{out} = 30 W PEP, I_{DQ} = 250 mA, f1 = 945.0 MHz, f2 = 945.1 MHz)	G _{ps}	18	20	-	dB
Two -Tone Drain Efficiency (V _{DD} = 26 Vdc, P _{out} = 30 W PEP, I _{DQ} = 250 mA, f1 = 945.0 MHz, f2 = 945.1 MHz)	η	37	41	_	%
3rd Order Intermodulation Distortion (V_{DD} = 26 Vdc, P_{out} = 30 W PEP, I_{DQ} = 250 mA, f1 = 945.0 MHz, f2 = 945.1 MHz)	IMD		-31	-28	dBc
Input Return Loss (V _{DD} = 26 Vdc, P _{out} = 30 W PEP, I _{DQ} = 250 mA, f1 = 945.0 MHz, f2 = 945.1 MHz)	IRL		-13	-9	dB
Two-Tone Common-Source Amplifier Power Gain (V_{DD} = 26 Vdc, P _{out} = 30 W PEP, I _{DQ} = 250 mA, f1 = 930.0 MHz, f2 = 930.1 MHz and f1 = 960.0 MHz, f2 = 960.1 MHz)	G _{ps}		20	_	dB
Two-Tone Drain Efficiency $(V_{DD} = 26 \text{ Vdc}, P_{out} = 30 \text{ W PEP}, I_{DQ} = 250 \text{ mA},$ f1 = 930.0 MHz, f2 = 930.1 MHz and f1 = 960.0 MHz, f2 = 960.1 MHz)	η		40.5	_	%
3rd Order Intermodulation Distortion (V_{DD} = 26 Vdc, P_{out} = 30 W PEP, I_{DQ} = 250 mA, f1 = 930.0 MHz, f2 = 930.1 MHz and f1 = 960.0 MHz, f2 = 960.1 MHz)	IMD	_	-31	_	dBc
Input Return Loss (V _{DD} = 26 Vdc, P _{out} = 30 W PEP, I _{DQ} = 250 mA, f1 = 930.0 MHz, f2 = 930.1 MHz and f1 = 960.0 MHz, f2 = 960.1 MHz)	IRL	—	-12	_	dB

Table 5. Electrical Characteristics(Tc = 25°c Unless Otherwise Noted)

ARCHIVE INFORMATION

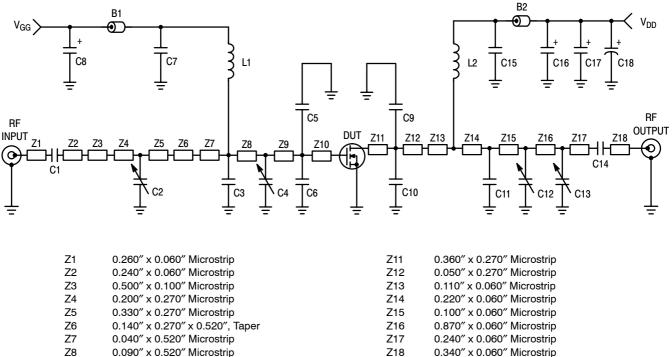


Figure 1. 930-960 MHz Broadband Test Circuit Schematic
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Board

Taconic RF-35-0300, $\varepsilon_r = 3.5$

Table 6, 930 -	- 960 MHz Broadband	Test Circuit Com	ponent Designations	and Value
Table 0. 300 -			poment Designations	

0.370" x 0.520" Microstrip (MRF9030MR1)

0.130" x 0.520" Microstrip (MRF9030MR1) 0.210" x 0.520" Microstrip (MRF9030MBR1)

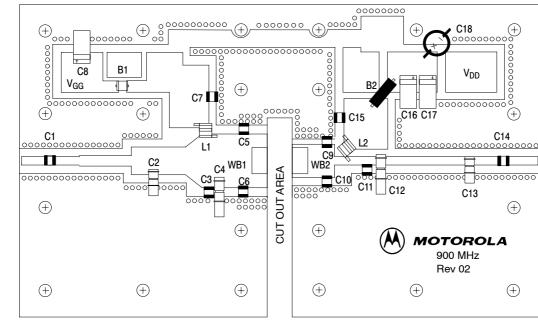
0.290" x 0.520" Microstrip (MRF9030MBR1)

Part	Description	Part Number	Manufacturer
B1	Short Ferrite Bead, Surface Mount	95F786	Newark
B2	Long Ferrite Bead, Surface Mount	95F787	Newark
C1, C7, C14, C15	47 pF Chip Capacitors	100B470JP 500X	ATC
C2	0.6-4.5 Variable Capacitor, Gigatrim	44F3360	Newark
C3, C11	3.9 pF Chip Capacitors	100B3R6BP 500X	ATC
C4, C12	0.8-8.0 Variable Capacitors, Gigatrim	44F3360	Newark
C5, C6	6.8 pF Chip Capacitors	100B7R5JP 500X	ATC
C8, C16, C17	10 μF, 35 V Tantulum Chip Capacitors	93F2975	Newark
C9, C10	10 pF Chip Capacitors	100B100JP 500X	ATC
C13	1.8 pF Chip Capacitor (MRF9030MR1) 0.6-4.5 Variable Capacitor, Gigatrim (MRF9030MBR1)	100B1R8BP 44F3360	ATC Newark
C18	220 µF Electrolytic Chip Capacitor	14F185	Newark
L1, L2	12.5 nH Coilcraft Inductors	A04T-5	Coilcraft
WB1, WB2	20 mil Brass Shim (0.250 x 0.250)	RF-Design Lab	RF-Design Lab
PCB	Etched Circuit Board	900 MHz µ250/Viper Rev 02	DSelectronics

Z9

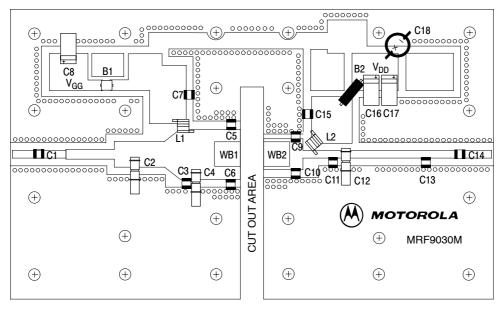
Z10





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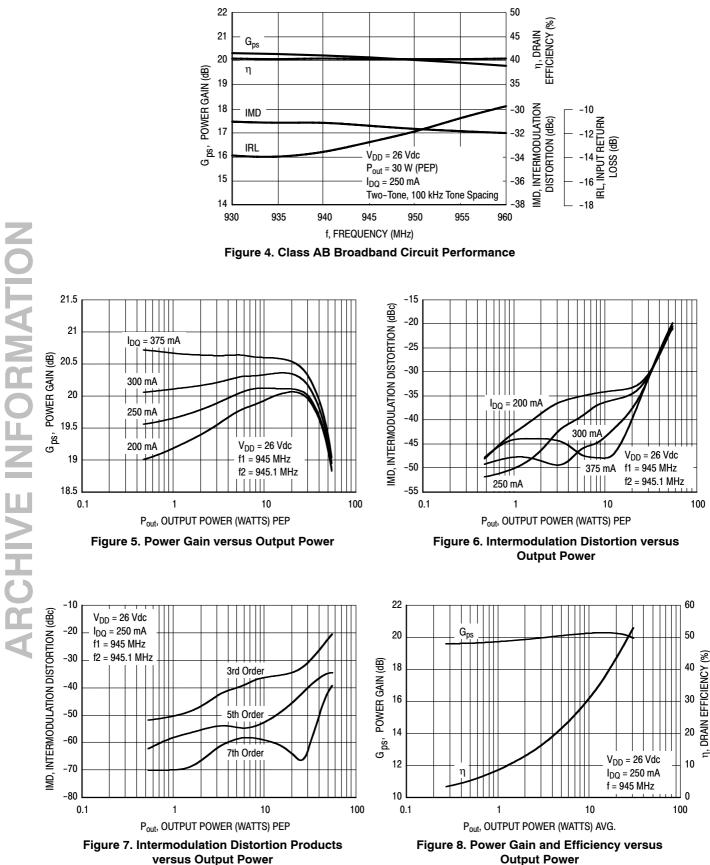


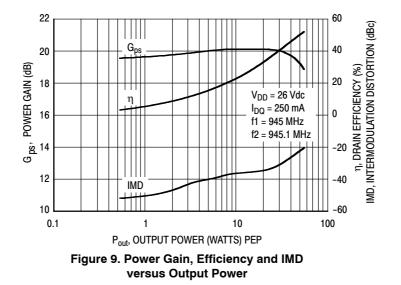


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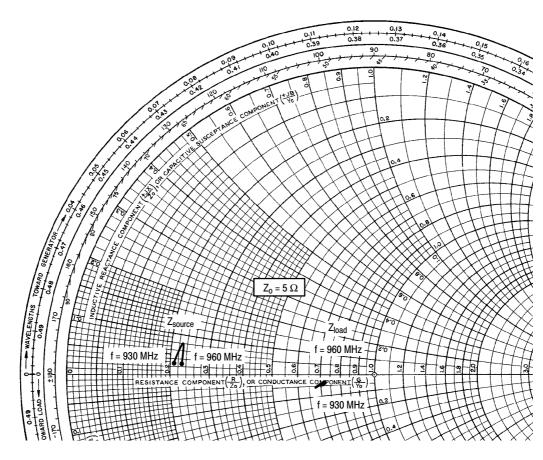


TYPICAL CHARACTERISTICS





RF Device Data Freescale Semiconductor



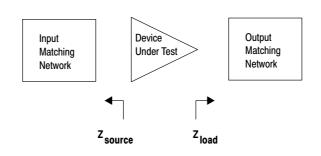
V_{DD} = 26 V, I_{DQ} = 250 mA, P_{out} = 30 Watts (PEP)

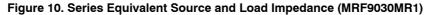
f MHz	z_{source}	Z_{load}
930	1.07 + j0.160	3.53 - j0.20
945	1.14 + j0.385	3.41 - j0.24
960	1.17 + j0.170	3.60 - j0.17

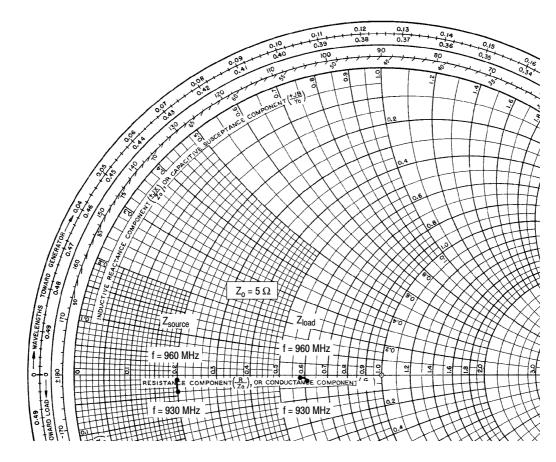
Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

Note: Z_{load} was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.





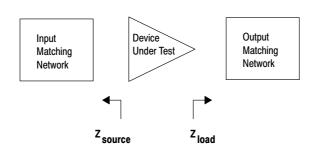


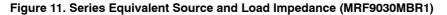
 V_{DD} = 26 V, I_{DQ} = 250 mA, P_{out} = 30 Watts (PEP)

f MHz	z_{source}	Z_{load}
930	1.0 - j0.18	3.05 - j0.09
945	1.0 - j0.10	3.00 - j0.07
960	1.0 - j0.03	2.95 - j0.03

Z_{source} = Test circuit impedance as measured from gate to ground.

Note: Z_{load} was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.





MRF9030MR1 MRF9030MBR1

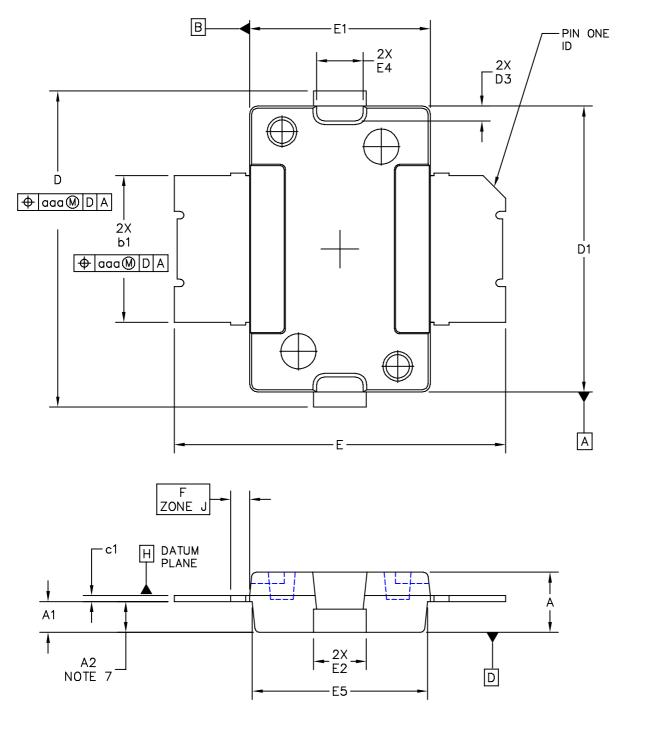
Z_{load} = Test circuit impedance as measured from drain to ground.

NOTES

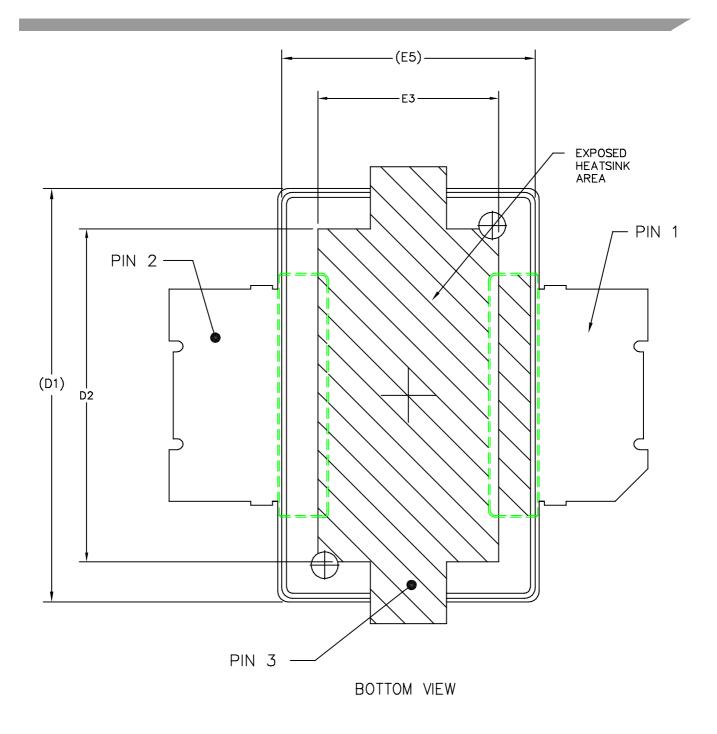
NOTES

NOTES

PACKAGE DIMENSIONS



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TITLE:		DOCUMENT NO): 98ASH98117A	REV: J
TO-270 SURFACE MOUN	Г	CASE NUMBER	: 1265–08	01 APR 2005
	1	STANDARD: NO	N-JEDEC	



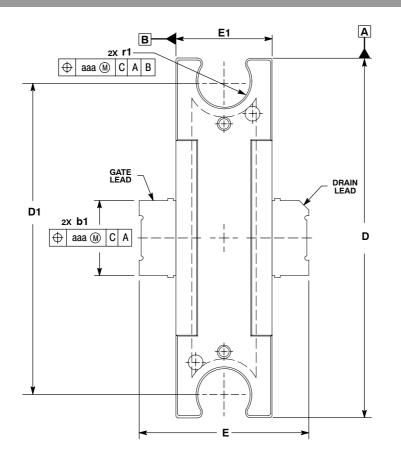
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TITLE:		DOCUMENT NO): 98ASH98117A	REV: J
TO-270 SURFACE MOUN	Г	CASE NUMBER	2: 1265–08	01 APR 2005
SURFACE MOUNT		STANDARD: NO	N-JEDEC	

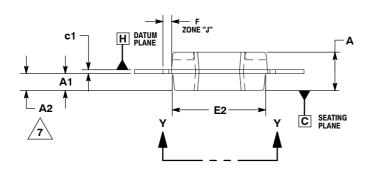
NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D1" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D1 AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 5. DIMENSION "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
- 7. DIMENSION "A2" APPLIES WITHIN ZONE "J" ONLY.
- 8. DIMENSIONS "D" AND "E2" DO NOT INCLUDE MOLD PROTRUSION. OVERALL LENGTH INCLUDING MOLD PROTRUSION SHOULD NOT EXCEED 0.430 INCH FOR DIMENSION "D" AND 0.080 INCH FOR DIMENSION "E2". DIMENSIONS "D" AND "E2" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -D-. STYLE 1:

	IN	СН	MI	LIMETER			INCH	м	ILLIMETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.078	.082	1.98	2.08	2.08 F .025 BSC 0.64		D.64 BSC		
A1	.039	.043	0.99	1.09	b1	.193	.199	4.90	5.06
A2	.040	.042	1.02	1.07	c1	.007	.011	0.18	3 0.28
D	.416	.424	10.57	10.77	aaa		.004		0.10
D1	.378	.382	9.60	9.70					
D2	.290	.320	7.37	8.13					
D3	.016	.024	0.41	0.61					
E	.436	.444	11.07	11.28					
E1	.238	.242	6.04	6.15					
E2	.066	.074	1.68	1.88					
E3	.150	.180	3.81	4.57					
E4	.058	.066	1.47	1.68					
E5	.231	.235	5.87	5.97					
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TITLE:	TITLE:				DOCU	MENT NO): 98ASH98117/	4	REV: J
	TO-270 SURFACE MOUNT				CASE	NUMBER	: 1265–08		01 APR 2005
	301			I	STAN	DARD: NO	N-JEDEC		

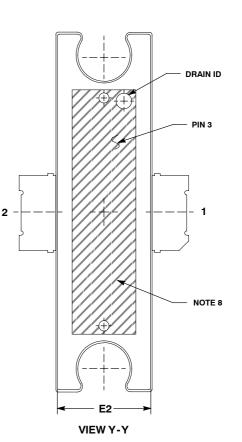
PIN 1 – DRAIN PIN 2 – GATE PIN 3 – SOURCE





STYLE 1: PIN 1. DRAIN 2. GATE 3. SOURCE

CASE 1337-03 **ISSUE C** TO-272-2 PLASTIC MRF9030MBR1



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 DIMENSION 'b1' DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION ALL DAMBAR PROTRUSION ALLOWABLE DAMB

	INC	HES	MILLIN	ETERS	
DIM	MIN	MAX	MIN	MAX	
Α	.100	.104	2.54	2.64	
A1	.039	.043	0.99	1.09	
A2	.040	.042	1.02	1.07	
D	.928	.932	23.57	23.67	
D1	.810 BSC		20.57 BSC		
Ε	.438	.442	11.12	11.23	
E1	.248	.252	6.30	6.40	
E2	.241	.245	6.12	6.22	
F	.025	BSC	0.64 BSC		
b1	.193	.199	4.90	5.05	
c1	.007	.011	.18	.28	
r1	.063	.068	1.60	1.73	
aaa	.0	04	.10		

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